

# MP7612

Octal 12-Bit DAC Array™  
D/A Converter with Output Amplifier  
and Serial Data/Address  
μP Control Logic



## FEATURES

- Eight Independent 12-Bit DACs with Output Amplifiers
- Low Power 320 mW (typ.)
- Serial Digital Data and Address Port (3-Wire Standard)
- 12-Bit Resolution, 11 Bit Accuracy
- Extremely Well Matched DACs
- Extremely Low Analog Ground Current (<60μA/Channel)
- ±10 V Output Swing with ±11.4 V Supplies
- Zero Volt Output Preset (Data = 10 .. 00)
- Rugged Construction – Latch-Up Free
- Parallel Version: MP7613

## APPLICATIONS

April 1996-4

- Data Acquisition Systems
- ATE
- Process Control
- Self-Diagnostic Systems
- Logic Analyzers
- Digital Storage Scopes
- PC Based Controller/DAS

## GENERAL DESCRIPTION

The MP7612 provides eight independent 12-bit resolution Digital-to-Analog Converters with voltage output amplifiers and a 3-wire standard serial digital address and data port.

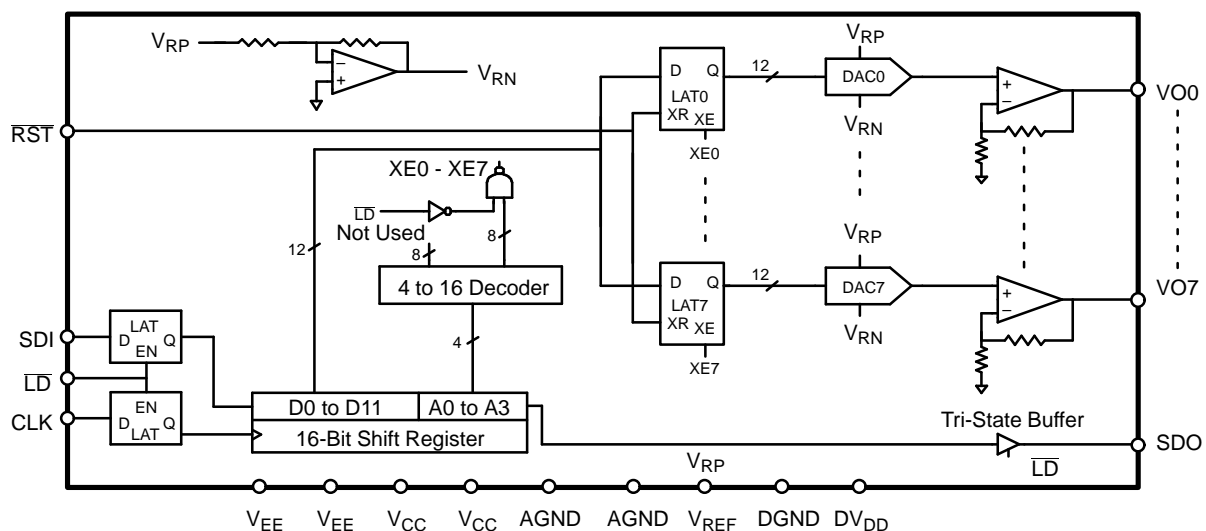
Typical DAC matching for B grade versions is 0.7 LSB across all codes. Accuracy of ±0.75 LSB for DNL and ±1 LSB for INL is also achieved for B grades. The output amplifier is capable of

sinking and sourcing 5mA, and the output voltage settles to 12-bits in less than 30μs (typ.).

The MP7612 is equipped with a serial data (3-wire standard) μ-processor logic interface to reduce pin count, package size, and board space.

Built using an advanced linear BiCMOS, these devices offer rugged solutions that are latch-up free, and take advantage of EXAR's patented thin-film resistor process which exhibits excellent long term stability and reliability.

## SIMPLIFIED BLOCK DIAGRAM



Rev. 3.00

©1996

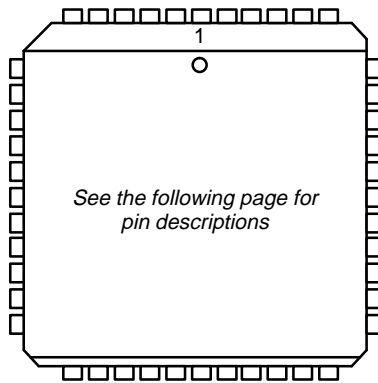


EXAR Corporation, 48720 Kato Road, Fremont, CA 94538 ♦ (510) 668-7000 ♦ FAX (510) 668-7010

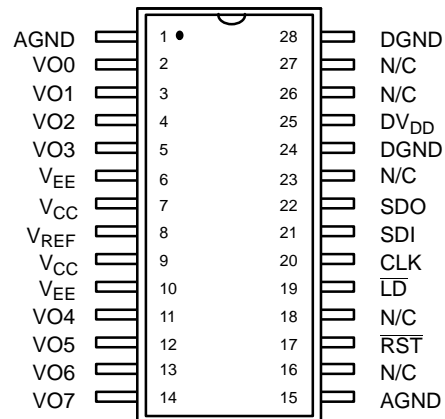
## ORDERING INFORMATION

Package Type	Temperature Range	Part No.	Res. (Bits)	INL (LSB)	DNL (LSB)	FSE (LSB)
PLCC	-40 to +85°C	MP7612BP	12	±1	±0.75	±6
PLCC	-40 to +85°C	MP7612AP	12	±2	±1	±8
SOIC	-40 to +85°C	MP7612BS	12	±1	±0.75	±6
SOIC	-40 to +85°C	MP7612AS	12	±2	±1	±8

## PIN CONFIGURATIONS



**44 Pin PLCC**



**28 Pin SOIC (Jedec, 0.346")**

## PIN DESCRIPTION

SOIC Pin #	PLCC Pin #	Symbol	Description
1	2	AGND	Analog Ground
2	3	VO0	DAC 0 Output
3	4	VO1	DAC 1 Output
4	5	VO2	DAC 2 Output
5	6	VO3	DAC 3 Output
6	7	V <sub>EE</sub>	Analog Negative Power Supply (-12 V)
7	9	V <sub>CC</sub>	Analog Positive Power Supply (+12 V)
8	12	V <sub>REF</sub>	Voltage Reference Input (+5 V)
9	13	V <sub>CC</sub>	Analog Positive Power Supply (+12 V)
10	15	V <sub>EE</sub>	Analog Negative Power Supply (-12 V)
11	18	VO4	DAC 4 Output
12	19	VO5	DAC 5 Output
13	20	VO6	DAC 6 Output
14	21	VO7	DAC 7 Output
15	24	AGND	Analog Ground
16		N/C	No Connection
17	26	$\overline{\text{RST}}$	Reset all DACs to 0 V Output
18		N/C	No Connection
19	29	$\overline{\text{LD}}$	Load Signal; Load Data to Selected DAC
20	31	CLK	Serial Data Clock
21	32	SDI	Serial Data Input
22	34	SDO	Shift Register Serial Output
23		N/C	No Connection
24	37	DGND	Digital Ground
25	40	DV <sub>DD</sub>	Digital Positive Power Supply (+5 V)
26		N/C	No Connection
27	1, 8, 10, 11, 14, 16, 17, 22, 23, 25, 27, 28, 30, 33, 35, 36, 38, 39, 41, 42, 43	N/C	No Connection
28	44	DGND	Digital Ground

## ELECTRICAL CHARACTERISTICS

$V_{CC} = +12\text{ V}$ ,  $V_{EE} = -12\text{ V}$ ,  $V_{REF} = 5\text{ V}$ ,  $DV_{DD} = 5.0\text{ V}$ ,  $T = 25^\circ\text{C}$ , Output Load =  $5\text{ k}\Omega$  (unless otherwise noted)

Parameter	Symbol	25°C			Tmin to Tmax		Units	Test Conditions/Comments
		Min	Typ	Max	Min	Max		
<b>STATIC PERFORMANCE</b>								
Resolution (All Grades)	N	12					Bits	
Integral Non-Linearity (Relative Accuracy)	INL						LSB	End Point Linearity Spec
A				$\pm 2$			$\pm 2$	
B				$\pm 1$			$\pm 1$	
Differential Non-Linearity	DNL						LSB	
A				$\pm 1$			$\pm 1$	
B				$\pm 0.75$			$\pm 0.75$	
Positive Full Scale Error	+FSE						LSB	
A		6		$\pm 8$			$\pm 8$	
B		4		$\pm 6$			$\pm 6$	
Negative Full Scale Error	-FSE						LSB	
A		6		$\pm 8$			$\pm 8$	
B		4		$\pm 6$			$\pm 6$	
Bipolar Zero Offset	ZOFS						LSB	
A				$\pm 4$			$\pm 4$	
B				$\pm 3$			$\pm 3$	
INL Matching	$\Delta$ INL						LSB	
A				$\pm 2$			$\pm 2$	
B				$\pm 1.5$			$\pm 1.5$	
All Channels Maximum Error with DAC 0 adjusted to minimum error	ME						LSB	
A				$\pm 4$			$\pm 4$	
B				$\pm 2$			$\pm 2$	
Bipolar Zero Matching	$\Delta$ ZOFS						LSB	
A				$\pm 4$			$\pm 4$	
B				$\pm 3$			$\pm 3$	
Full Scale Error Matching	FSE						LSB	
A				$\pm 4$			$\pm 4$	
B				$\pm 3$			$\pm 3$	
<b>DYNAMIC PERFORMANCE</b>								
Voltage Settling from $\overline{\text{LD}}$ to VDAC Out <sup>1</sup>	$t_{sd}$		30	50		50	$\mu\text{sec}$	ZS to FS (20 V Step)
Channel-to-Channel Crosstalk <sup>1, 6</sup>	CT		0.04				LSB	DC
Digital Feedthrough <sup>1, 6</sup>	Q		-70				dB	CLK and Data to $V_{OUTi}$
Power Supply Rejection Ratio	PSRR			5			ppm/%	$\Delta V_{EE}$ & $\Delta V_{CC} = \pm 5\%$ , ppm of FS
<b>REFERENCE INPUTS</b>								
Impedance of $V_{REF}$	REF	350	700	1.05k	350	1.05k	$\Omega$	See Application Hints for driving the reference input
$V_{REF}$ Voltage <sup>1, 2</sup>	$V_{REF}$	3.5		6			V	

## ELECTRICAL CHARACTERISTICS (CONT'D)

Parameter	Symbol	25°C			Tmin to Tmax		Units	Test Conditions/Comments
		Min	Typ	Max	Min	Max		
<b>DIGITAL INPUTS<sup>3</sup></b>								
Logic High	$V_{IH}$	2.4					V	
Logic Low	$V_{IL}$			0.8			V	
Input Current	$I_L$			$\pm 10$			$\mu A$	
Input Capacitance <sup>1</sup>	$C_L$			8			pF	
<b>ANALOG OUTPUTS</b>								
Output Swing		$-V_{EE} + 1.4$	$V_{CC} - 1.4$				V	
Output Drive Current		-5		5			mA	
Output Impedance	$R_O$		1				$\Omega$	
Output Short Circuit Current	$I_{SC}$		25				mA	+FS to AGND
			30				mA	+FS to $V_{EE}$
			40				mA	-FS to AGND
			55				mA	-FS to $V_{CC}$
<b>DIGITAL OUTPUTS</b>								
Output High Voltage	$V_{OH}$		4.5				V	
Output Low Voltage	$V_{OL}$		0.5				V	
<b>POWER SUPPLIES</b>								
$V_{CC}$ Voltage <sup>5</sup>	$V_{CC}$	$V_{REF} + 1.5$	12	12.75	$V_{REF} + 1.5$	12.75	V	
$V_{EE}$ Voltage <sup>5</sup>	$V_{EE}$	-12.75	-12	-5	-12.75	-5	V	
DVDD Voltage	DVDD	4.5	5	5.5	4.5	5.5	V	
Positive Supply Current	$I_{CC}$		8	10		10	mA	Bipolar zero
Negative Supply Current	$I_{EE}$		15	20		20	mA	Bipolar zero
Digital Supply Current	$I_{DD}$			2		2	mA	Bipolar zero
Power Dissipation	PD <sub>ISS</sub>		320	420		450	mW	Bipolar zero
<b>ANALOG GROUND CURRENT</b>								
Per Channel <sup>1</sup>	$I_{AGND}$		$\pm 60$				$\mu A$	See Application Notes
<b>DIGITAL TIMING SPECIFICATIONS<sup>1,4</sup></b>								
Input Clock Pulse Width	$t_{CH}, t_{CL}$		35				ns	$V_{IL} = 0, V_{IH} = 5.0, C_L = 20 \text{ pF}$  Note: $t_{LD}$ and $t_{CKLD2}$ cannot both be min. since $t_{CKLD1} = t_{CKLD2} + t_{LD}$
Data Setup Time	$t_{DS}$		15				ns	
Data Hold Time	$t_{DH}$		15				ns	
CLK to SDO Propagation Delay	$t_{PD}$			40			ns	
DAC Register Load Pulse Width	$t_{LD}$		35				ns	
Preset Pulse Width	$t_{PR}$		50				ns	
Clock Edge to Load Time	$t_{CKLD1}$		140				ns	
	$t_{CKLD2}$		0				ns	
$\overline{LD}$ Falling Edge to SDO Tri-state Enable	$t_{HZ1}$		50				ns	
$\overline{LD}$ Rising Edge to SDO Tri-state Disable	$t_{HZ2}$		50				ns	
$\overline{LD}$ Rising Edge to CLK Enable	$t_{LDCK}$		50				ns	
$\overline{LD}$ Set-up Time with Respect to CLK	$t_{LDSU}$		30				ns	

## ELECTRICAL CHARACTERISTICS (CONT'D)

### NOTES:

- 1 Guaranteed; not tested.
- 2 Specified values guarantee functionality.
- 3 Digital inputs should not go below digital GND or exceed DV<sub>DD</sub> supply voltage.
- 4 See Figures 2 and 3. All digital input signals are specified with t<sub>R</sub> = t<sub>F</sub> = 10 ns 10% to 90% and timed from a 50% voltage level.
- 5 For power supply values <math>\pm 2 \times V\_{REF}</math>, the output swing is limited as specified in Analog Outputs.
- 6 Digital feedthrough and channel-to-channel crosstalk are heavily dependent on the board layout and environment.

Specifications are subject to change without notice

### ABSOLUTE MAXIMUM RATINGS (TA = +25°C unless otherwise noted)<sup>1, 2</sup>

V <sub>CC</sub> to AGND	+16.5 V	Analog Inputs & Outputs	Indefinite Shorts to V <sub>CC</sub> , V <sub>EE</sub> , DV <sub>DD</sub> , AGND, DGND (provided that power dissipation of the package spec is not exceeded)
V <sub>EE</sub> to AGND	-16.5 V	Operating Temperature Range	
DV <sub>DD</sub> to DGND	+6.5 V	Extended Industrial	-40°C to +85°C
V <sub>REF</sub> to DGND	+7.0 V	Maximum Junction Temperature	-65°C to 150°C
AGND to DGND	±1 V (Functionality guaranteed for ±0.5 V only)	Storage Temperature	150°C
Digital Input & Output Voltage to DGND	-0.5 to DV <sub>DD</sub> +0.5V	Lead Temperature (Soldering, 10 sec)	+300°C
		Package Power Dissipation Rating @ 75°C	
		SOIC, PLCC	1150mW
		Derates above 75°C	15mW/°C

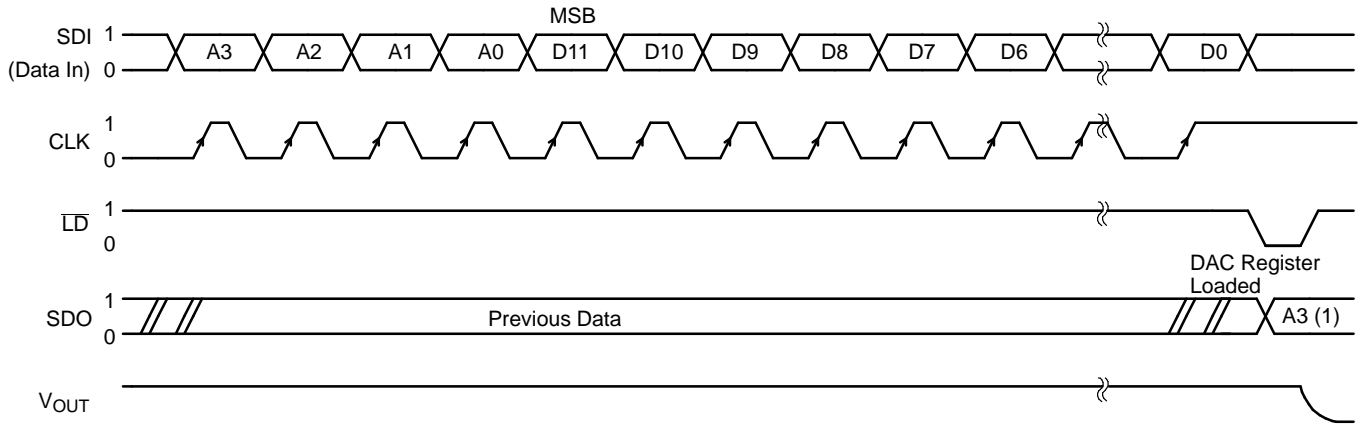
### NOTES:

- 1 Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation at or above this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.
- 2 Any input pin which can see a value outside the absolute maximum ratings should be protected by Schottky diode clamps (HP5082-2835) from input pin to the supplies. All inputs have protection diodes which will protect the device from short transients outside the supplies of less than 100mA for less than 100µs.

### APPLICATION NOTES

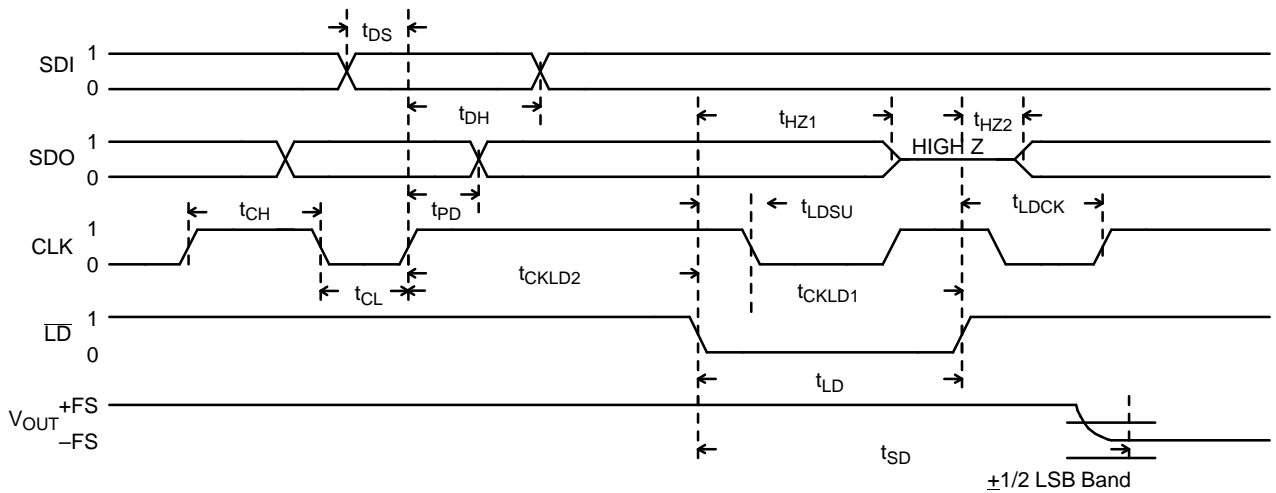
**Refer to Section 8 in the 1995 Data Acquisition products Databook for Applications Information**

NOTE: When using these DACs to drive remote devices, the accuracy of the output can be improved by utilizing a remote analog ground connection. The difference between the DGND and AGND should be limited to ±300 mV to assure normal operation. If there is any chance that the AGND to DGND can be greater than ±1 V, we recommend two back-to-back diodes be used between DGND and AGND to clamp the voltage and prevent damage to the DAC. Using a buffer between the remote ground location and AGND may help reduce noise induced from long lead or trace lengths.



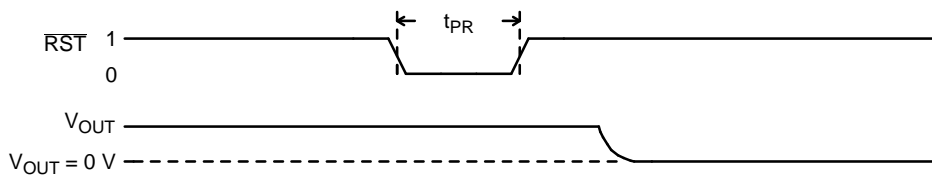
Notes: (1) Because A3 is available immediately after 16th clock edge of DATA Shift-in, only 15 clock cycles are needed to complete the readback.

**Figure 1. Serial Data Timing and Loading**



Notes: (1) CLK should be high during the falling edge of  $\overline{LD}$  to insure proper function of the shift register.

**Figure 2. Serial Data Input Timing ( $\overline{RST} = "1"$ )**



Note: Reset settling time is  $\leq t_{SD}$  ±1/2 LSB Error Band

**Figure 3. Reset Operation**

The MP7612 is equipped with a serial data (3-wire standard)  $\mu$ -processor logic interface to reduce pin count, package size, and board wire (space). If the  $\overline{\text{LD}}$  signal is high, the CLK signal loads the digital input bits (SDI) into the shift register (4 bits address A3 to A0 plus 12 bits data DB11 to DB0 for the MP7612). The  $\overline{\text{LD}}$  signal going low loads the data into the selected DAC.

The  $\overline{\text{LD}}$  signal going low also disables the serial data (SDI), output (SDO 3-stated) and the CLK input. This design tremendously reduces digital noise and glitch transients into the DACs due to free running CLK and SDI. Note also that the preset signal ( $\overline{\text{RST}}$ ) resets all analog outputs to 0 volt regardless of digital inputs.

Function	A3	A2	A1	A0	$\overline{\text{LD}}$	CLK	$\overline{\text{RST}}$	SDI	SDO
Shift Data In and Out	X	X	X	X	1	0→1 Repeat	1	Data Input Valid	Data Output Valid
Stop Shifting Data In and Out	X	X	X	X	0	X	1	X	Hi-Z
Load DACs	0	0	0	0	No Operation				
DAC 0	0	0	0	1	1→0	X	1	X	Hi-Z
DAC 1	0	0	1	0	1→0	X	1	X	Hi-Z
DAC 2	0	0	1	1	1→0	X	1	X	Hi-Z
DAC 3	0	1	0	0	1→0	X	1	X	Hi-Z
DAC 4	0	1	0	1	1→0	X	1	X	Hi-Z
DAC 5	0	1	1	0	1→0	X	1	X	Hi-Z
DAC 6	0	1	1	1	1→0	X	1	X	Hi-Z
DAC 7	1	0	0	0	1→0	X	1	X	Hi-Z
⋮	⋮	⋮	⋮	⋮	No Operation	X	⋮	⋮	⋮
⋮	⋮	⋮	⋮	⋮	⋮	X	⋮	⋮	⋮
⋮	1	1	1	0	No Operation	X	1	X	Hi-Z
⋮	1	1	1	1	No Operation	X	1	X	Hi-Z
Reset all DACs to 0 V	X	X	X	X	X	X	0	X	X

**Table 1. Digital Function Truth Table  
Serial In/Serial Out**

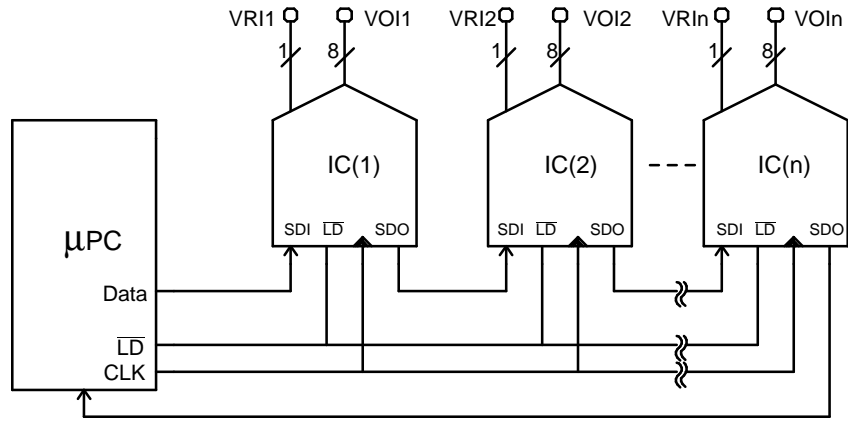
*Note: For timing information see Electrical Characteristics*



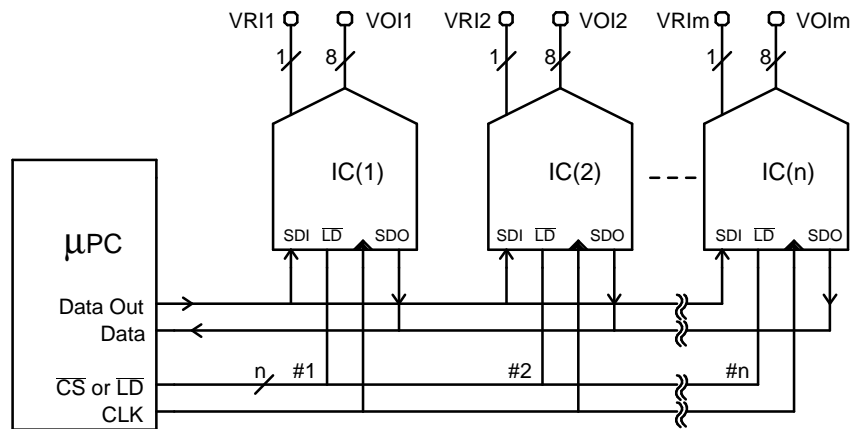
Hex Code	Binary Code	Output Voltage = $2 \cdot V_r \left(-1 + \frac{2 \cdot D}{4096}\right)$ ( $V_r = +5 \text{ V}$ )
0 0 0	000000000000	$10 \cdot (-1 + 0) = -10$
⋮	⋮	⋮
7 F F	011111111111	$10 \cdot \left(-1 + \frac{4094}{4096}\right) = -4.88 \text{ mV}$
8 0 0	100000000000	$10 \cdot \left(-1 + \frac{4096}{4096}\right) = 0$
8 0 1	100000000001	$10 \cdot \left(-1 + \frac{4098}{4096}\right) = 4.88 \text{ mV}$
⋮	⋮	⋮
F F F	111111111111	$10 \cdot \left(-1 + \frac{8190}{4096}\right) = 9.99512$

**Table 2. MP7612  
Ideal DAC Output vs. Input Code**

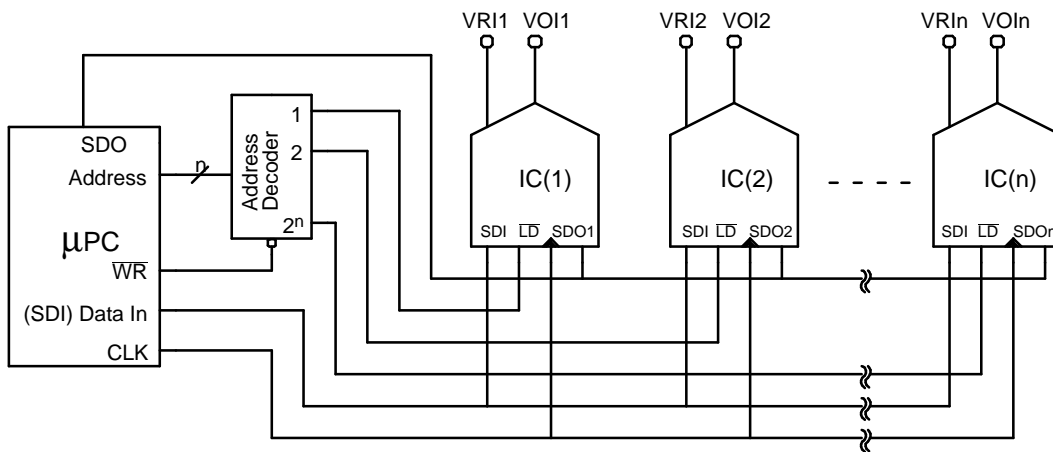
**Note: See Electrical Characteristics for real system accuracy**



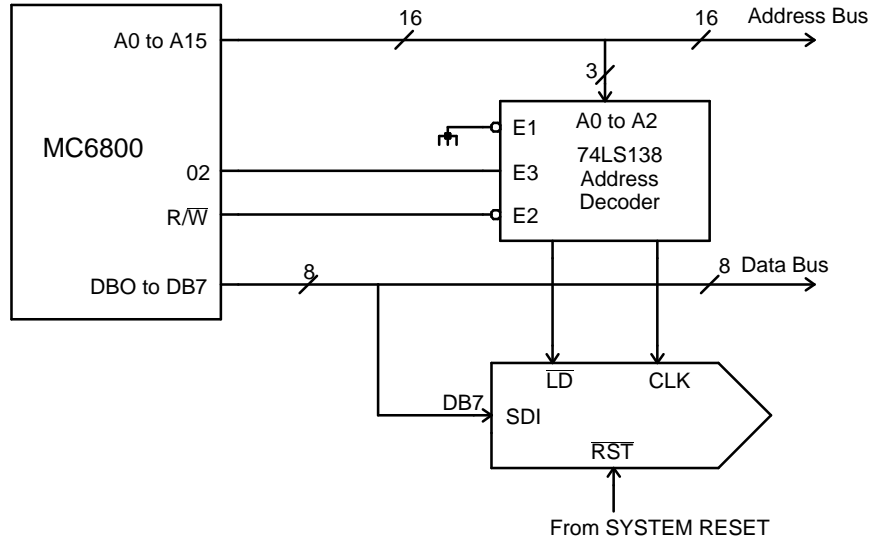
**Figure 4. Simplified Diagram**



**Figure 5. Simplified Diagram**



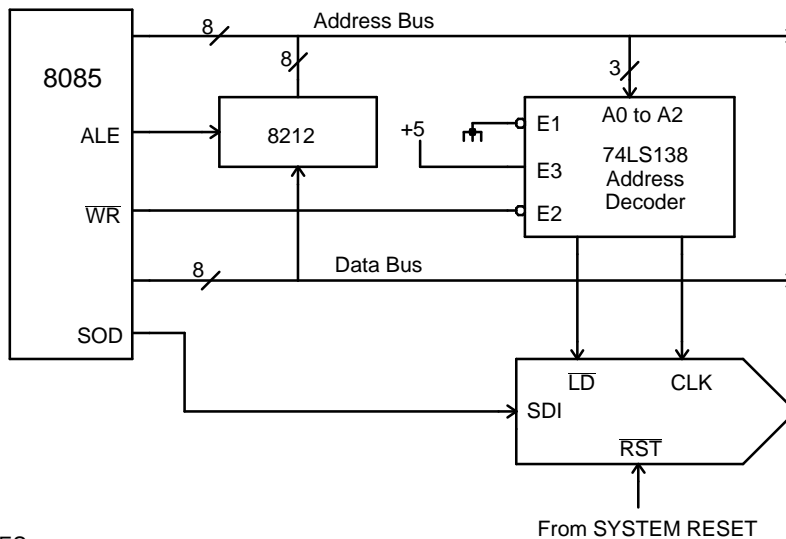
**Figure 6. Simplified Diagram**



**NOTES**

1. Execute consecutive memory write instructions while manipulating the data between WRITES so that each WRITE presents the next bit.
2. The serial data loading is triggered by the CLK pulse which is asserted by a decoded memory WRITE to memory location 2000, R/W, and 02. A WRITE to address 4000 transfers data from input shift register to DAC register.

**Figure 7. MC6800 Interface**

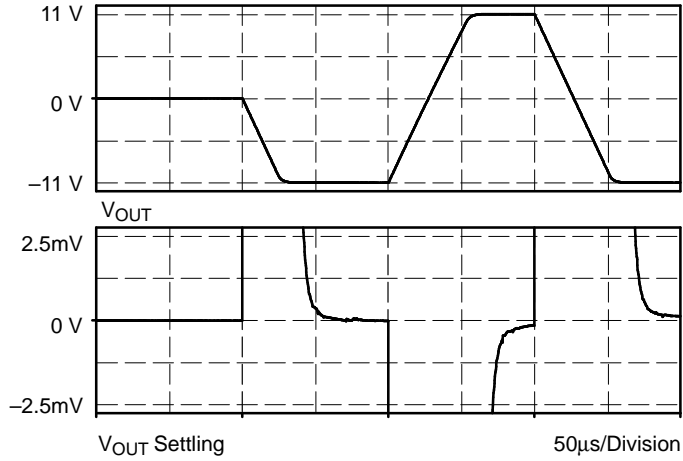


**NOTES:**

1. Clock generated by  $\overline{WR}$  and decoding address 8000.
2. Data is clocked in the DAC shift register by executing memory write instructions. The clock input is generated by decoding address 8000 and  $\overline{WR}$ . Data is then loaded into the DAC register with a memory write instruction to address 4000.
3. Serial data must be present in the right justified format in registers H & L of the microprocessor.

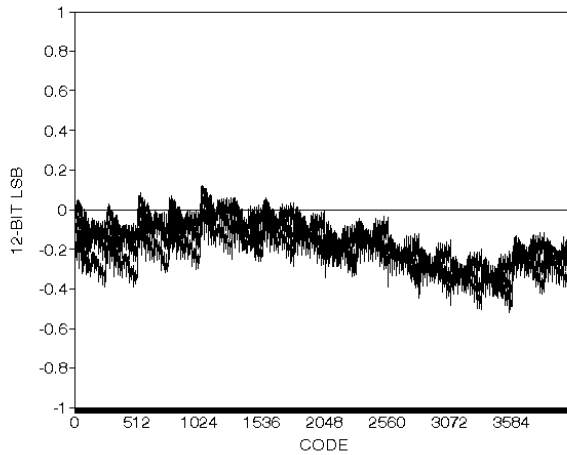
**Figure 8. 8085 Interface**

## PERFORMANCE CHARACTERISTICS

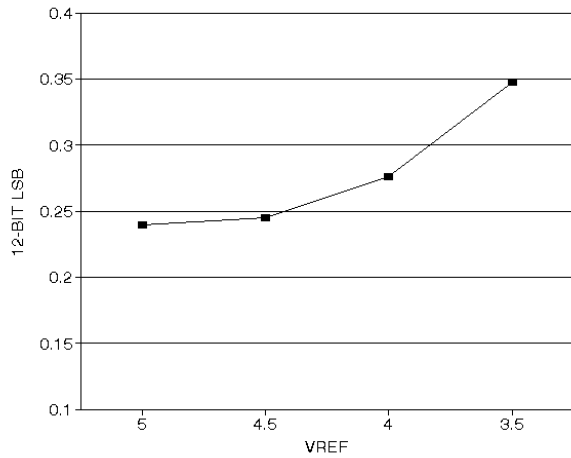


**Graph 1. Typical Output Settling Characteristic**  
 $V_{REF} = 5\text{ V}$ ,  $R_L = 5\text{ K}$ ,  $C_L = 500\text{ pF}$

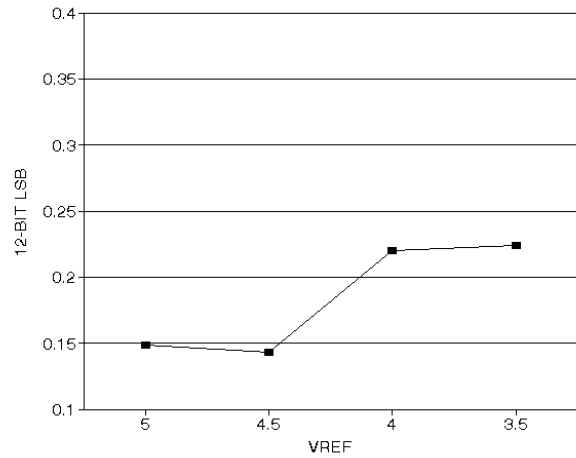
Graph 1 shows the typical output settling characteristic of the MP7610 Family for a RESET → ZS → FS → ZS series of code transitions. The top graph shows the output voltage transients, while the bottom graph shows the difference between the output and the ideal output.



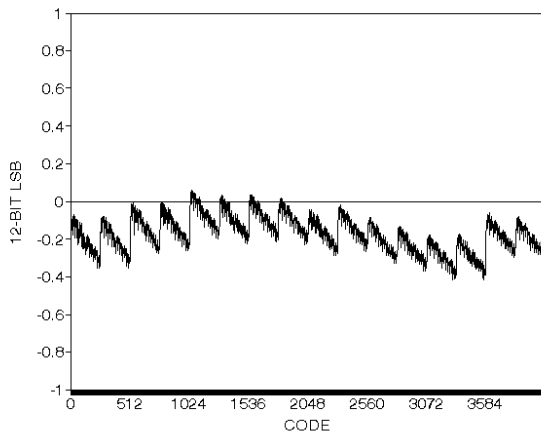
**Graph 2. Linearity with**  
 $V_{REF} = 5\text{ V}$ , All DACs, All Codes



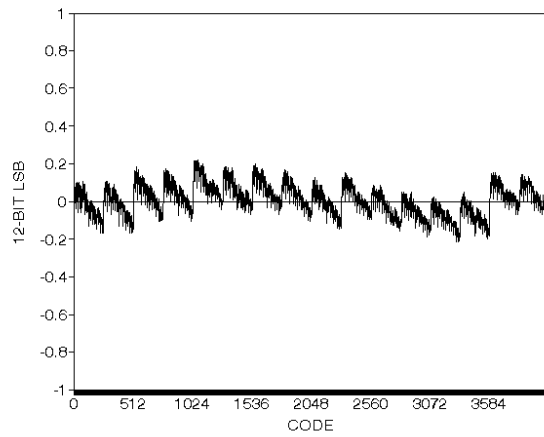
**Graph 3. DAC 0 INL vs. VREF**



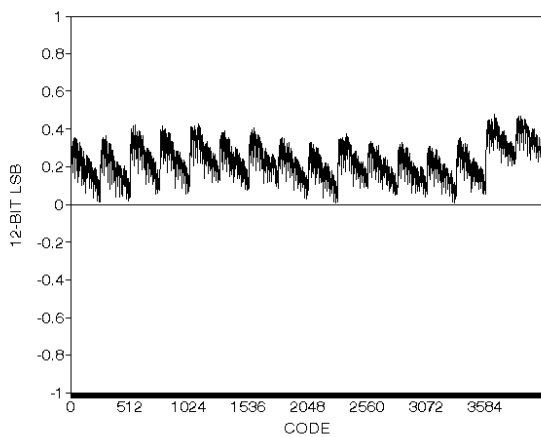
**Graph 4. DAC 0 DNL vs. VREF**



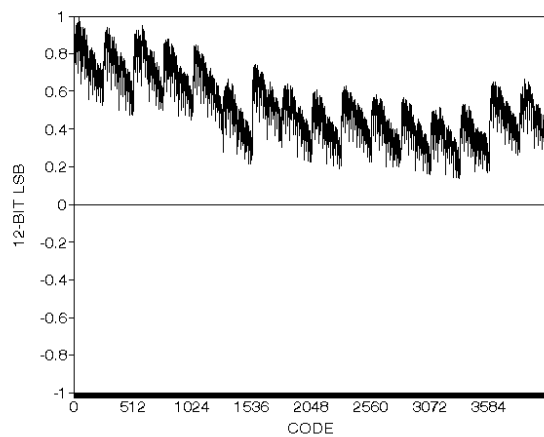
**Graph 5. DAC 0 Linearity with VREF = 5 V, VOUT = ±10**



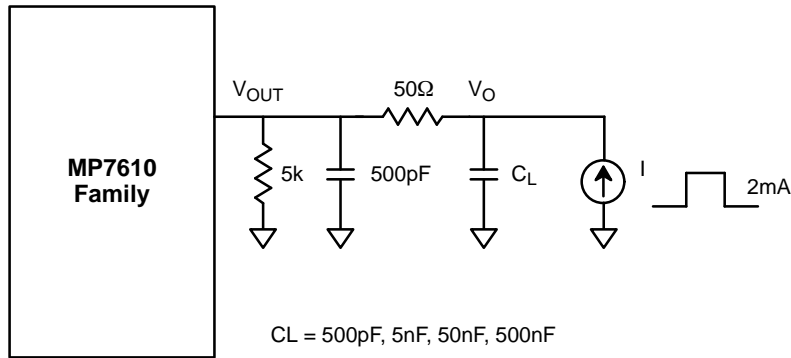
**Graph 6. DAC 0 Linearity with VREF = 4.5 V, VOUT = ±9**



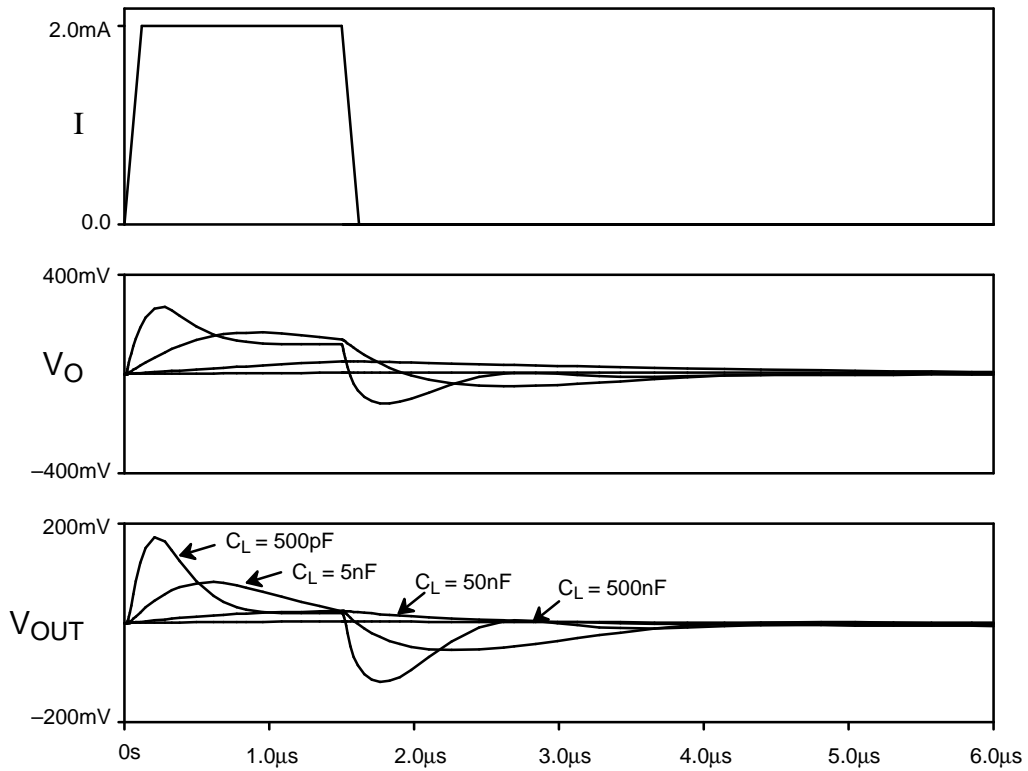
**Graph 7. DAC 0 Linearity with VREF = 4 V, VOUT = ±8**



**Graph 8. DAC 0 Linearity with VREF = 3.5 V, VOUT = ±7**

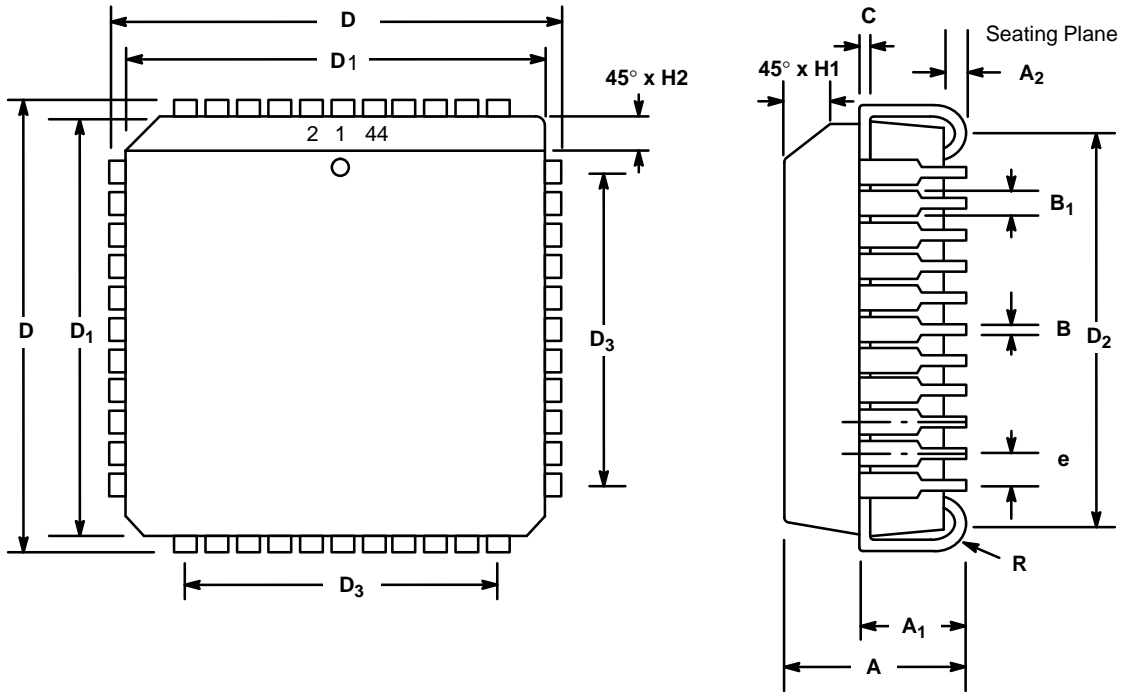


**Figure 9. Circuit for Determining Typical Analog Output Pulse Response**



**Graph 9. Typical Response of the MP7610 Family Analog Output to a Current Pulse with  $C_L=500pF, 5nF, 50nF, 500nF$  (See Figure 9. above)**

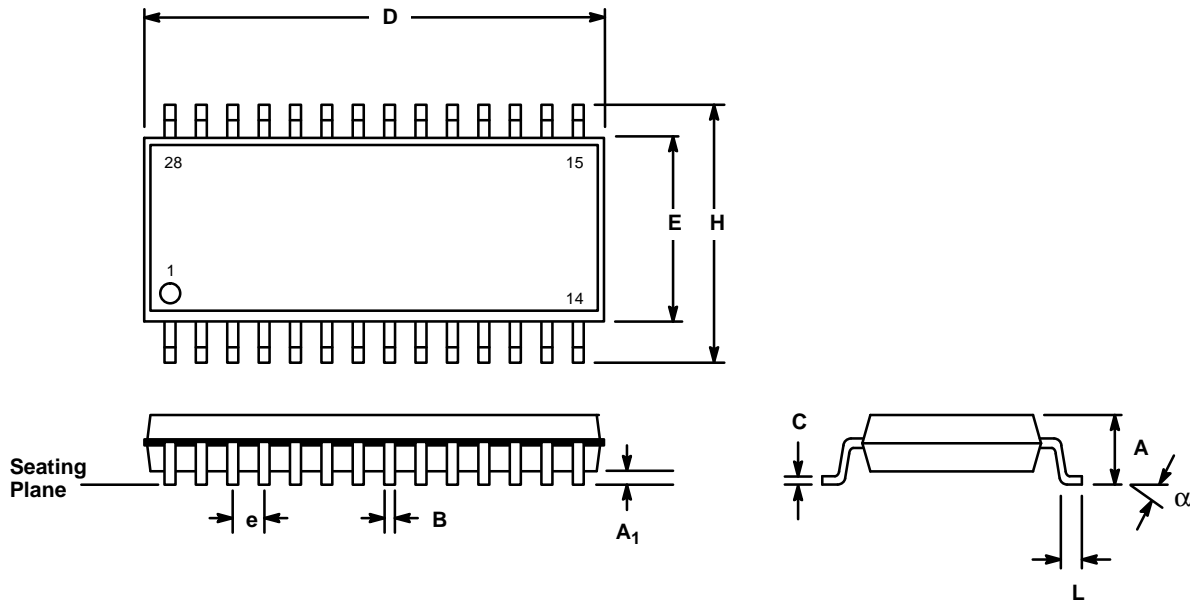
**44 LEAD PLASTIC LEADED CHIP CARRIER  
(PLCC)**



SYMBOL	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.165	0.180	4.19	4.57
A <sub>1</sub>	0.090	0.120	2.29	3.05
A <sub>2</sub>	0.020	—	0.51	—
B	0.013	0.021	0.33	0.53
B <sub>1</sub>	0.026	0.032	0.66	0.81
C	0.008	0.013	0.19	0.32
D	0.685	0.695	17.40	17.65
D <sub>1</sub>	0.650	0.656	16.51	16.66
D <sub>2</sub>	0.590	0.630	14.99	16.00
D <sub>3</sub>	0.500 typ.		12.70 typ.	
e	0.050 BSC		1.27 BSC	
H <sub>1</sub>	0.042	0.056	1.07	1.42
H <sub>2</sub>	0.042	0.048	1.07	1.22
R	0.025	0.045	0.64	1.14

Note: The control dimension is the inch column

## 28 LEAD SMALL OUTLINE (350 MIL JEDEC SOIC)



SYMBOL	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.093	0.104	2.35	2.65
A <sub>1</sub>	0.004	0.012	0.10	0.30
B	0.013	0.020	0.33	0.51
C	0.009	0.013	0.23	0.32
D	0.706	0.718	17.93	18.24
E	0.340	0.350	8.64	8.89
e	0.050 BSC		1.27 BSC	
H	0.460	0.485	11.68	12.32
L	0.016	0.050	0.40	1.27
$\alpha$	0°	8°	0°	8°

Note: The control dimension is the millimeter column



# Notes

# Notes

# Notes

## NOTICE

EXAR Corporation reserves the right to make changes to the products contained in this publication in order to improve design, performance or reliability. EXAR Corporation assumes no responsibility for the use of any circuits described herein, conveys no license under any patent or other right, and makes no representation that the circuits are free of patent infringement. Charts and schedules contained here in are only for illustration purposes and may vary depending upon a user's specific application. While the information in this publication has been carefully checked; no responsibility, however, is assumed for inaccuracies.

EXAR Corporation does not recommend the use of any of its products in life support applications where the failure or malfunction of the product can reasonably be expected to cause failure of the life support system or to significantly affect its safety or effectiveness. Products are not authorized for use in such applications unless EXAR Corporation receives, in writing, assurances to its satisfaction that: (a) the risk of injury or damage has been minimized; (b) the user assumes all such risks; (c) potential liability of EXAR Corporation is adequately protected under the circumstances.

Copyright 1993 EXAR Corporation

Datasheet April 1996

Reproduction, in part or whole, without the prior written consent of EXAR Corporation is prohibited.